

Notice of References Cited

Application/Control No.

09/847,525

Applicant(s)/Patent Under
Reexamination
CHAN ET AL.

Examiner

Mark L. Berch

Art Unit

1624

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-5,672,598	09-1997	De et al.	514/212.03
X	B	US-5,672,600	09-1997	Demuth et al.	514/224.5
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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